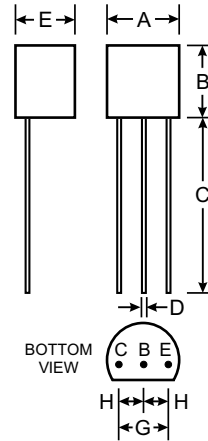


**Features**

- Epitaxial Planar Die Construction
- Available in Both Through-Hole and Surface Mount Packages
- Suitable for Switching and Amplifier Applications
- Complementary NPN Types Available (2N3904)

**Mechanical Data**

- Case: TO-92, Molded Plastic
- Leads: Solderable per MIL-STD-202, Method 208
- Terminal Connections: See Diagram
- Marking: Type Number
- Weight: 0.18 grams (approx.)



TO-92		
Dim	Min	Max
A	4.32	4.83
B	4.32	4.78
C	12.50	15.62
D	0.36	0.56
E	3.15	3.94
G	2.29	2.79
H	1.14	1.40
All Dimensions in mm		

**Maximum Ratings** @  $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic	Symbol	2N3906	Unit
Collector-Base Voltage	$V_{CB0}$	-40	V
Collector-Emitter Voltage	$V_{CE0}$	-40	V
Emitter-Base Voltage	$V_{EB0}$	-5.0	V
Collector Current - Continuous	$I_C$	-100	mA
Collector Current - Peak	$I_{CM}$	-200	mA
Power Dissipation (Note 1)	$P_d$	500	mW
Thermal Resistance, Junction to Ambient (Note 1)	$R_{\theta JA}$	250	K/W
Operating and Storage Temperature Range	$T_j, T_{STG}$	-55 to +150	$^\circ\text{C}$

- Notes: 1. Leads maintained at a distance of 2.0mm from body at specified ambient temperature.  
 2. Pulse test: Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .

**Electrical Characteristics** @  $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic	Symbol	Min	Max	Unit	Test Condition
DC Current Gain	$h_{FE}$	50 70 100 60 30	— — 300 — —	—	$-V_{CE} = 1.0V, -I_C = 0.1mA$ $-V_{CE} = 1.0V, -I_C = 1.0mA$ $-V_{CE} = 1.0V, -I_C = 10mA$ $-V_{CE} = 1.0V, -I_C = 50mA$ $-V_{CE} = 1.0V, -I_C = 100mA$
Collector Saturation Voltage	$V_{CE(SAT)}$	—	0.25 0.40	V	(Note 2) $-I_C = 10mA, -I_B = 1.0mA$ $-I_C = 50mA, -I_B = 5.0mA$
Base Saturation Voltage	$V_{BE(SAT)}$	—	0.85 0.95	V	(Note 2) $-I_C = 10mA, -I_B = 1.0mA$ $-I_C = 50mA, -I_B = 5.0mA$
Collector Cutoff Current	$I_{CEX}$	—	50	nA	$-V_{EB} = 3.0V, -V_{CE} = 30V$
Emitter Cutoff Current	$I_{BL}$	—	50	nA	$-V_{EB} = 3.0V, -V_{CE} = 30V$
Collector-Base Breakdown Voltage	$V_{(BR)CBO}$	40	—	V	$-I_C = 10\mu A, -I_E = 0$
Collector-Emitter Breakdown Voltage	$V_{(BR)CEO}$	40	—	V	$-I_C = 1.0mA, -I_B = 0$ (Note 2)
Emitter-Base Breakdown Voltage	$V_{(BR)EBO}$	5.0	—	V	$-I_E = 10\mu A, -I_C = 0$
Gain Bandwidth Product	$f_T$	250	—	MHz	$-V_{CE} = 20V, -I_C = 10mA,$ $f = 100MHz$
Collector-Base Capacitance	$C_{CBO}$	—	4.5	pF	$-V_{CB} = 5.0V, -I_E = 0, f = 100kHz$
Emitter-Base Capacitance	$C_{EBO}$	—	10	pF	$-V_{EB} = 0.5V, -I_C = 0, f = 100kHz$
Noise Figure	NF	—	5.0	dB	$-V_{CE} = 5.0V, -I_C = 100\mu A,$ $R_G = 1.0k\Omega, f = 10$ to $15000Hz$
Delay Time	$t_d$	—	35	ns	$-I_{B1} = 1.0mA, -I_C = 10mA,$ $V_{CC} = 3.0V, V_{BE(off)} = 0.5V$
Rise Time	$t_r$	—	35	ns	$-I_{B1} = 1.0mA, -I_C = 10mA,$ $-V_{CC} = 3.0V, -V_{BE(off)} = 0.5V$
Storage Time	$t_s$	—	225	ns	$-I_{B1} = -I_{B2} = 1.0mA,$ $-I_C = 10mA, -V_{CC} = 3.0V$
Fall Time	$t_f$	—	75	ns	$-I_{B1} = -I_{B2} = 1.0mA,$ $-I_C = 10mA, -V_{CC} = 3.0V$

- Notes: 1. Leads maintained at a distance of 2.0mm from body at specified ambient temperature.  
2. Pulse test: Pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .

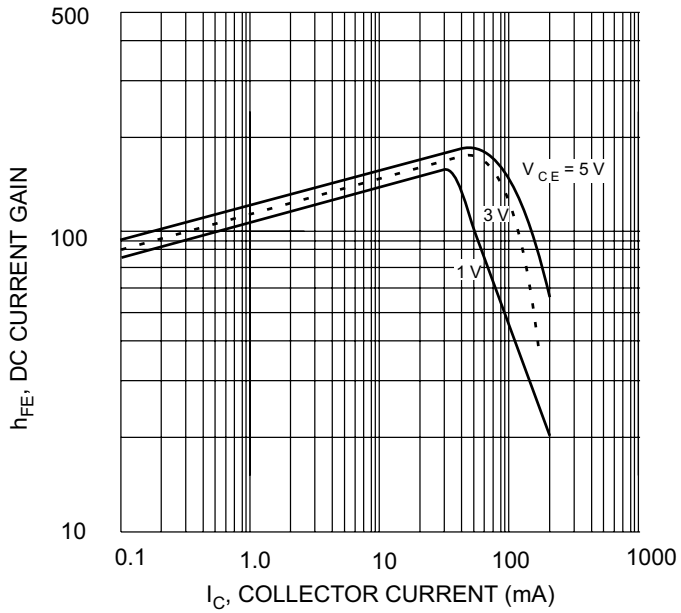


Fig. 1, DC Current Gain vs Collector Current

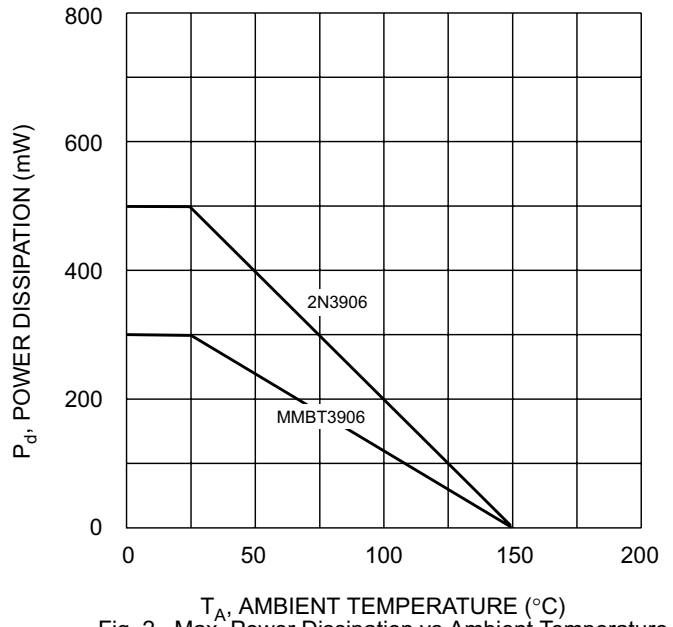


Fig. 2, Max Power Dissipation vs Ambient Temperature

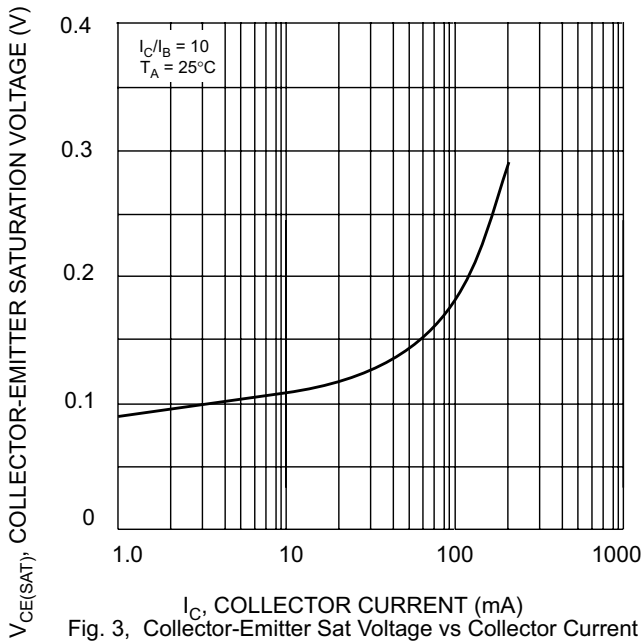


Fig. 3, Collector-Emitter Sat Voltage vs Collector Current

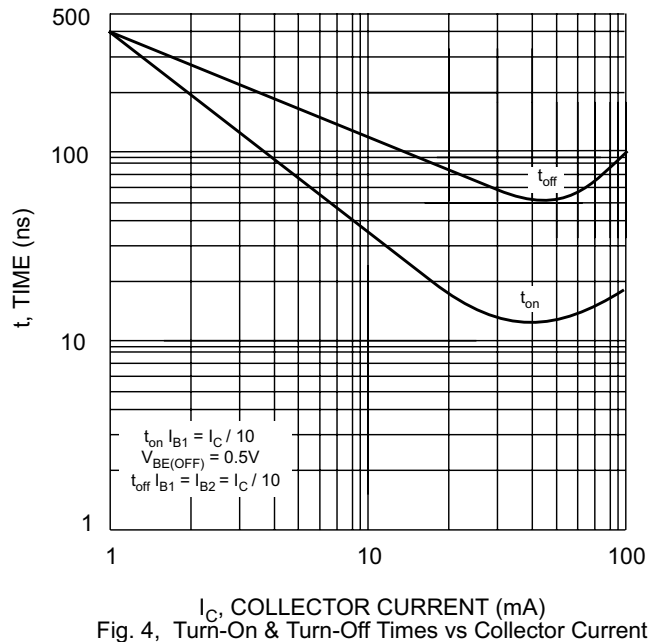


Fig. 4, Turn-On & Turn-Off Times vs Collector Current